Conference Programme 17th May - Training



Time (BST)	Title	Presenter				
Click here to join the Training Session						
Chair: Wenjuan Sun & David Gorman						
09:00 - 10:00	ISO Geometrical Product Specification (ISO GPS). An investigation into size abstract	lain Macleod Chair of the ISO/TC 213 technical committee (responsible for ISO GPS standards)				
10:00 - 11:00	CT advancements for production line measurement	Chris Price Nikon Metrology				
11:00 - 11:15	Break					
11:15 - 12:15	Virtual CT with "aRTist" abstract	Carsten Bellon Bundesanstalt für Material- forschung und -prüfung, Germany				
12:15 - 13:00	Lunch					
13:00 - 14:00	What's new in Volume Graphics' VGSTUDIO MAX 3.5	Ashley Bray, Volume Graphics				
14:00 - 15:00	Introduction of TIGRE image reconstruction toolbox for dimensional XCT application abstract	Manuchehr Soleimani, University of Bath Ander Biguri, UCL				

Conference Programme 18th May - Session I



Time (BST)	Title [MS Teams Breakout/Poster/Virtual Booth]	Presenter [email]
09:00 - 09:05	Conference Open	Wenjuan Sun
09:05 - 09:10	Welcome Talk	Ben Hughes
	Session 1: Metrology and Advanced Technology Session chair: Wenjuan Sun	
09:10 - 09:40	Keynote 1: #01 Dimensional X-ray CT and advanced materials manufacturing - abstract	Philip J. Withers
09:40 - 09:55	#02 A critical assessment of the "improved two-spheres method" for the determination of a structural resolution for dXCT - abstract	René Laquai
09:55 - 10:10	#03 Improving the accuracy of dimensional measurements with high resolution X-ray computed tomography microscopes - abstract	Herminso Villarraga -Gómez
10:10 - 10:25	#04 Determination of structural resolution from reconstructed volume data - abstract	Joachim Stopp
10:25 - 10:40	Break	
10:40 - 10:45	Announcement: Introducing the National Facility in X-ray CT	Jay Warnett
10:45 - 11:00	#05 High-resolution x-ray tomography through super-resolution - abstract	Till Dreier
11:00 - 11:15	#06 Tomographic Imaging Performed Using A Laser Wakefield Driven X- ray Source - abstract	Christopher Thornton
11:15 - 11:30	#07 Applying the appropriate correction mapping for volumetric surface compensation on additively manufactured parts - abstract	Gerd Schwaderer
11:30 - 11:45	#08 Geometry Estimation for Fixed-Gantry CT Scanner - abstract	Wail Mustafa
11:45 - 12:00	Break	
12,00 12,20	Breakout Rooms: #01 - #02 - #03 - #04 - #05 - #06 - #07 - #08 Poster 1: Investigation of the partial volume effect on XCT metrology of AM surfaces - abstract Go to Poster Session - View the extended abstract Poster 2: Effect of detector in-plane rotation misalignment on dimensional	Xiao Chen
12:00 - 12:30	measurements using helical CT acquisition - abstract Go to Poster Session - View the extended abstract Virtual Booth: Nikon Virtual Booth: North Star Imaging Virtual Booth: Virtual Booth: ThermoFisher Scientific	Pavel Blazek
12.20 (2.00	Virtual Booth: CCPi	
12:30 - 13:00	Lunch	

Conference Programme 18th May - Session 2



Title [MS Teams Breakout/Poster/Virtual Booth]	Presenter [email]			
Session 2: Traceability and Calibration Session chair: Martin Turner				
Commercial Talk: CCPi Tomographic Imaging	Edoardo Pasca			
Commercial Talk: North Star Imaging	Guy Tolley			
Commercial Talk: Nikon Metrology	Richard Frisk			
Commercial Talk: Hamamatsu	Simon Whitbread			
Keynote 2 #09 EMPIR AdvanCT – Project overview and CT-corrections developed by PTB - abstract	Ulrich Neuschaefer- Rube			
Traceable sub-microfocus X-ray focal spot reconstruction by circular edge analysis - abstract	Felix Meli			
Calibration of X-ray computed tomography for surface texture measurement using metrological characteristics - abstract	Adam Thompson			
Novel Method to Assess Segmentation Routines in a Multi-material Component - abstract	David Gorman			
EMPIR AdvanCT - CT measurement uncertainty of freeform surfaces - abstract	Josef Frese			
Day 2 – Closing Announcements				
Break				
Breakout Rooms: #09 - #10 - #11 - #12 - #13				
Poster 3: MPE statements for metrology XCT systems - abstract Go to Poster Session - View the extended abstract	Evelien Zwanenburg			
Poster 4: Visualisation and interpretation of volumetric differences - abstract Go to Poster Session - View the extended abstract	Gerd Schwaderer			
Virtual Booth: Nikon Virtual Booth: North Star Imaging				
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	Session 2: Traceability and Calibration Session chair: Martin Turner Commercial Talk: CCPi Tomographic Imaging Commercial Talk: North Star Imaging Commercial Talk: Nikon Metrology Commercial Talk: Hamamatsu Keynote 2 EMPIR AdvanCT – Project overview and CT-corrections developed by PTB - abstract Traceable sub-microfocus X-ray focal spot reconstruction by circular edge analysis - abstract Calibration of X-ray computed tomography for surface texture meas- urement using metrological characteristics - abstract Novel Method to Assess Segmentation Routines in a Multi-material Component - abstract EMPIR AdvanCT - CT measurement uncertainty of freeform surfaces - abstract Day 2 - Closing Announcements Break Break Sreakout Rooms: #09 - #10 - #11 - #12 - #13 Poster 3: MPE statements for metrology XCT systems - abstract Go to Poster Session - View the extended abstract Abstract Coster 4: Visualisation and interpretation of volumetric differences - abstract Go to Poster Session - View the extended abstract			

Conference Programme 19th May - Session 3



Time (BST)	Title [MS Teams Breakout/Poster/Virtual Booth]	Presenter [email]		
09:00 - 09:05	Morning Announcements			
Session 3: Applications				
Session chair: Paul Bills				
	Keynote 3			
09:05 - 09:35	#14 X-ray computed tomography for aerospace applications - abstract	Wenjuan Sun		
09:35 - 09:50	#15 Automatic Defect Recognition and Sentencing of Low Density Materials used in HED Physics Experiments - abstract	Leigh J. Reed		
09:50 - 10:05	#16 The surface area and localised 3D roughness of a highly structured surface using X-Ray Computed tomography (XCT) - abstract	John .W. McBride		
10:05 - 10:20	#17 Improvement of reconstruction results using prior information from CAD model for sparse-view Computed Tomography - abstract	Julie Escoda		
10:20 - 10:35	#18 Case study about the influence of temperature and humidity for di- mensional measurements on polymer parts - abstract	Lorenzo Carli		
10:35 - 10:40	Commercial Talk: Diondo	Nick Brierley		
10:40 - 10:45	Commercial Talk: Volume Graphics	Gerd Schwaderer		
10:45 - 10:50	Commercial Talk: Thermo Fisher Scientific	John Carron		
10:50 - 10:55	Commercial Talk: Tescan	Lars Oliver Kautschor		
10:55 - 11:20	Break			
	Poster 4: Visualisation and interpretation of volumetric Differences - abstract Go to Poster Session - View the extended abstract	Gerd Schwaderer		
11:20 - 11:50	Poster 1 : Investigation of the partial volume effect on XCT metrology of AM surfaces - abstract	Xiao Chen		
	Go to Poster Session - View the extended abstract			
	Virtual Booth: Nikon Virtual Booth: North Star Imaging			
	Virtual Booth: Volume Graphics Virtual Booth: ThermoFisher Scientific			
11:50 - 12:30	Virtual Booth: CCPi Lunch			
11.30 - 12.30	Lulicii			

Conference Programme 19th May - Session 4



Time (BST)	Title [MS Teams Breakout/Poster/Virtual Booth]	Presenter [email]		
Session 4: Traceability and Modelling				
	Session chair: Jay Warnett			
12:30 - 13:00	Keynote 4 #20 Methods for traceable compensation of machine geometry deviations in industrial computed tomography - abstract	Benjamin A. Bircher		
13:00 - 13:15	9 Degree of freedom characterisation of xCT and uncertainty for co- #21 ordinate system using GUM approach - abstract	Ville Heikkinen		
13:15 - 13:30	#22 AdvanCT virtual CT - abstract	Carsten Bellon		
13:30 - 13:45	Integration of geometric deviations of system components with a re- #23 duced set of parameters for computed tomography simulations in aRTist - abstract	Felix Binder		
13:45 - 14:00	The application of watershed algorithm in surface determination in #24 XCT dimensional metrology - abstract	Xiuyuan Yang		
14:00 - 14:15	Coffee Break			
14:15 - 14:45	Breakout Rooms:#20 - #21 - #22 - #23 - #24Poster 2: Effect of detector in-plane rotation misalignment on dimensional measurements using helical CT acquisition - abstractGo to Poster Session - View the extended abstractPoster 3: MPE statements for metrology XCT systems - abstractGo to Poster Session - View the extended abstractVirtual Booth: NikonVirtual Booth: North Star ImagingVirtual Booth: Volume GraphicsVirtual Booth: ThermoFisher ScientificVirtual Booth: CCPi	Pavel Blazek Evelien Zwanenburg		
14:45 – 15:00	Update on ISO standards	Sarah Kelly		
15:00 - 15:30	Panel discussion/question time	Lead by Adam Thompson		
15:30 - 15:40	Awards	Wenjuan Sun		
15:40 - 15:50	Announcement: Future events	Tristan Lowe		
15:50 - 16:00	Conference Close	Wenjuan Sun		